UNISONIC TECHNOLOGIES CO., LTD

13N40K-MT P1

Preliminary

Power MOSFET

13A, 400V N-CHANNEL POWER MOSFET

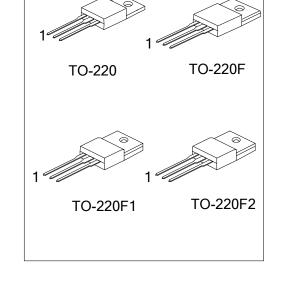
DESCRIPTION

The UTC 13N40K-MT is an N-channel mode power MOSFET using UTC's advanced technology to provide customers with planar stripe and DMOS technology. This technology specializes in allowing a minimum on-state resistance and superior switching performance. It also can withstand high energy pulse in the avalanche and commutation mode.

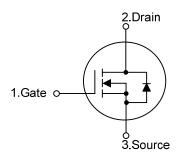
The UTC **13N40K-MT** is universally applied in electronic lamp ballast based on half bridge topology and high efficient switched mode power supply.



- * $R_{DS(ON)}$ < 0.35 Ω @ V_{GS} = 10 V, I_{D} = 6.5 A
- * High switching speed
- * 100% avalanche tested



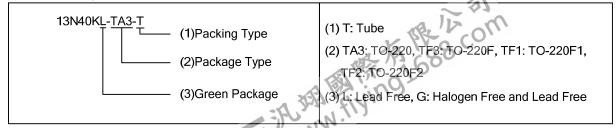
■ SYMBOL



ORDERING INFORMATION

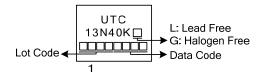
Ordering Number		Daokago	Pin Assignment			Dooking	
Lead Free	Halogen Free	Package	1	2	3	Packing	
13N40KL-TA3-T	13N40KG-TA3-T	TO-220	G	D	S	Tube	
13N40KL-TF3-T	13N40KG-TF3-T	TO-220F	G	D	S	Tube	
13N40KL-TF1-T	13N40KG-TF1-T	TO-220F1	G	D	S	Tube	
13N40KL-TF2-T	13N40KG-TF2-T	TO-220F2	G	D	S	Tube	

Note: Pin Assignment: G: Gate D: Drain S: Source



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MARKING





■ ABSOLUTE MAXIMUM RATINGS (T_C=25°C, unless otherwise specified)

PARAMETER		SYMBOL	RATINGS	UNIT
Drain-Source Voltage		V_{DSS}	400	V
Gate-Source Voltage		V_{GSS}	±30	V
Drain Current	Continuous (T _C =25°C)	I _D	13	Α
	Pulsed (Note 2)	I_{DM}	52	Α
Avalanche Energy	Single Pulsed (Note 3)	E _{AS}	507	mJ
Power Dissipation	TO-220		143	W
	TO-220F/TO-220F1 TO-220F2	5	34	W
Derate above 25°C	TO-220	P_{D}	1.14	W/°C
	TO-220F/TO-220F1 TO-220F2		0.272	W/°C
Junction Temperature		TJ	+150	°C
Storage Temperature Range		T_{STG}	-55~+150	°C

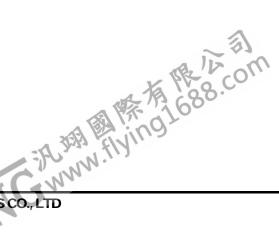
Notes: 1. Absolute maximum ratings are those values beyond which the device could be permanently damaged.

Absolute maximum ratings are stress ratings only and functional device operation is not implied.

- 2. Repetitive Rating: Pulse width limited by maximum junction temperature
- 3. L = 6mH, I_{AS} = 13A, V_{DD} = 50V, R_{G} = 25 Ω , Starting T_{J} = 25 $^{\circ}$ C
- 4. I_{SD}≤13A, di/dt≤200A/µs, V_{DD}≤BV_{DSS}, Starting T_J=25°C

■ THERMAL DATA

PARAMETER		SYMBOL	RATINGS	UNIT
Junction to Ambient		θ_{JA}	62.5	°C/W
Junction to Case	TO-220		0.87	°C/W
	TO-220F/TO-220F1 TO-220F2	θ_{JC}	3.58	°C/W



ELECTRICAL CHARACTERISTICS (T_C=25°C, unless otherwise noted)

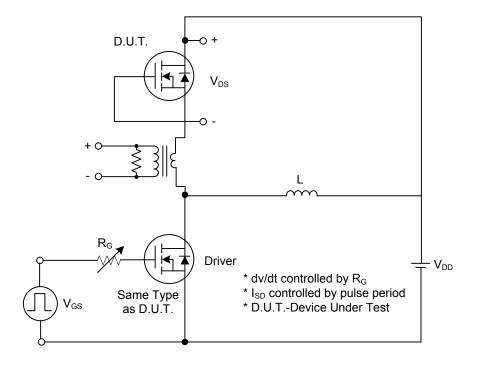
PARAMETER		SYMBOL	TEST CONDITIONS		TYP	MAX	UNIT
OFF CHARACTERISTICS							
Drain-Source Breakdown Voltage		BV _{DSS}	I _D =250μA, V _{GS} =0V				V
Drain-Source Leakage Current		I _{DSS}	V _{DS} =400V, V _{GS} =0V			1	μΑ
Gate- Source Leakage Current	Forward	- I _{GSS}	V_{GS} =+30V, V_{DS} =0V			+100	nA
	Reverse		V_{GS} =-30V, V_{DS} =0V			-100	nA
ON CHARACTERISTICS							
Gate Threshold Voltage		$V_{GS(TH)}$	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$			4.0	V
Static Drain-Source On-State Re	sistance	R _{DS(ON)}	V_{GS} =10V, I_{D} =6.5A		0.29	0.35	Ω
DYNAMIC PARAMETERS				_			
Input Capacitance		C _{ISS}			775		pF
Output Capacitance		Coss	V_{GS} =0V, V_{DS} =25V, f=1.0MHz		165		pF
Reverse Transfer Capacitance		C_{RSS}			11.5		pF
SWITCHING PARAMETERS		_			-		-
Total Gate Charge		Q_G	V - 50V V - 40V I - 0.3A		32	100	nC
Gate-Source Charge		Q_GS	V_{DS} = 50V, V_{GS} = 10V, I_{D} = 0.3A, I_{D} =100 μ A (Note 1, 2)		9.4	12	nC
Gate-Drain Charge		Q_GD	1D-100μΑ (Note 1, 2)		8.3	55	nC
Turn-ON Delay Time		t _{D(ON)}			64		ns
Rise Time		t_R	V_{DS} = 30V, V_{GS} = 10V, I_{D} = 0.3A,		87		ns
Turn-OFF Delay Time		t _{D(OFF)}	$R_G = 25\Omega \text{ (Note 1, 2)}$		160		ns
Fall-Time		t _F			89		ns
SOURCE- DRAIN DIODE RATIF	NGS AND	CHARACTERI	STICS				
Drain-Source Diode Forward Voltage		V_{SD}	I _S =13A, V _{GS} =0V			1.4	V
Maximum Body-Diode Continuous Current		Is				13	Α
Maximum Body-Diode Pulsed Current		I _{SM}				52	Α

Notes: 1. Pulse Test: Pulse width ≤ 300µs, Duty cycle ≤ 2%

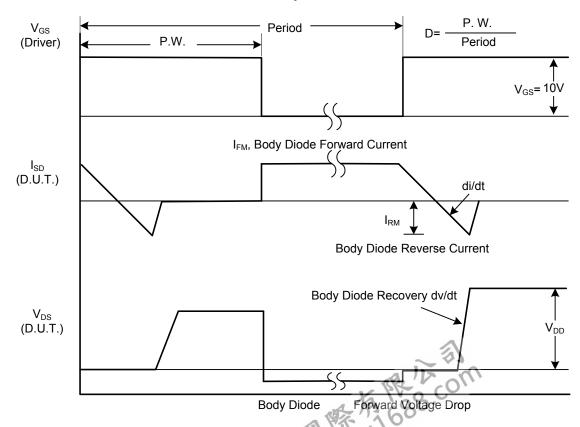


^{2.} Essentially independent of operating temperature

■ TEST CIRCUITS AND WAVEFORMS

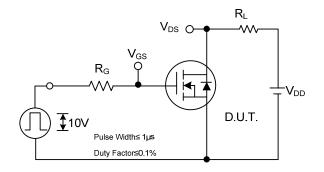


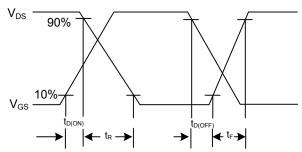
Peak Diode Recovery dv/dt Test Circuit



Peak Diode Recovery dv/dt Waveforms

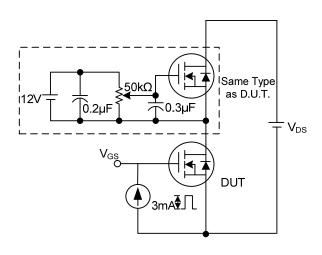
TEST CIRCUITS AND WAVEFORMS (Cont.)

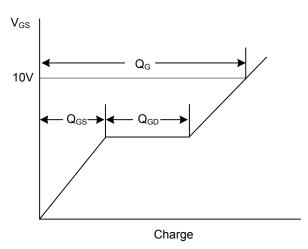




Switching Test Circuit

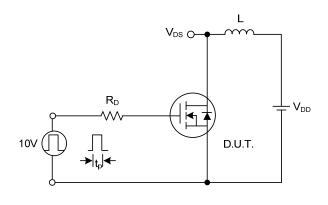
Switching Waveforms

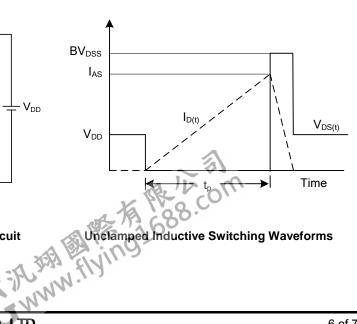




Gate Charge Test Circuit

Gate Charge Waveform





Unclamped Inductive Switching Test Circuit

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